VDSS

500V



N Channel MOSFET

P6

RDS(ON)(Typ.)

 0.27Ω

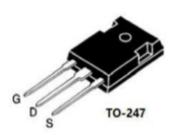
Lead Free Package and Finish

Applications:

- •Adapter & Charger
- •DC-AC inverter Power
- •AC-DC Switching Power Supply
- •LED driving power

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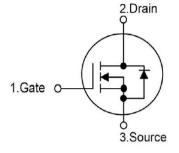
- •Low On Resistance
- Low Gate Charge
- •Peak Current vs Pulse Width Curve
- •RoHS Compliant



Not to Scale

ID

18A



Ordering Information:

Part Number	Package	Marking
RS18N50W	TO-247	RS18N50W

Absolute Maximun Ratings Tc=25℃ unless otherwise specified

Symbol	Parameter	RS18N50W	Units	
VDSS	Drain-to-Source Voltage (Note*1)	500	V	
ID	Continuous Drain Current	18.0		
ID@ 100 ℃	Continuous Drain Current	9.0	Α	
lом	Pulsed Drain Current (Note*2)	72.0		
PD	Power Dissipation	98	W	
VGS	Gate-to-Source Voltage	±30	V	
EAS	Single Pulse Avalanche Engergy IAS=14A VDD=50V RG=25Ω Starting TJ=25℃	998	mJ	
	Maximum Temperature for Soldering			
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds	300 260	${\mathbb C}$	
	Package Body for 10 seconds		C	
TJ and TSTG	Operating Junction and Storage	-55 to 150]	
13 and 131G	Temperature Range	-33 to 130		

^{*}Drain Current Limited by Maximum Junction Temperature

Caution:Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.

Thermal Resistance

Symbol	Parameter	RS18N50W	Units	Test Conditions
RθJC	Junction-to-Case	0.43	°C/W	Drain lead soldered to water cooled heatsink,PD adjusted for a peak junction temperature of +150℃.
RθJA	Junction-to-Ambient	41		1 cubic foot chamber,free air.

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OFF Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain-to-source Breakdown Voltage	500			V	Vgs=0V,ID=250µA
IDSS	Drain-to-Source Leakage Current			1.0	μΑ	VDS=500V,VGS=0V
loco	Gate-to-Source Forward Leakage			100	۸	Vgs=+30V Vds=0V
Igss	Gate-to-Source Reverse Leakage			-100	μA	Vgs=-30V Vds=0V

ON Characteristics TJ=25℃ unless otherwise specified

Symbol	Parameter Parameter		Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain-to-Source On-Resistance		0.27	0.32	Ω	V _{GS} =10V,I _D =9A
Vgs(TH)	Gate Threshold Voltage	3.0		4.0	V	Vgs=Vds,Id=250µA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn-on Delay Time		35			V _{DS} =250V
trise	Rise Time		50		nS	I _D =18A
td(OFF)	Turn-OFF Delay Time		180		113	$R_G = 25\Omega$
tfall	Fall Time		65			(Note:3,4)

Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		2250			Vgs=0V
Coss	Output Capacitance		231		pF	Vps=25V
Crss	Reverse Transfer Capacitance		36			f=1.0MHz
Qg	Total Gate Charge		71			V _{DS} =400V
Qgs	Gate-to-Source Charge		10.0		nC	I _D =18A
Qgd	Gate-to-Drain("Miller") Charge		32			V _{GS} =10V (Note:3,4)

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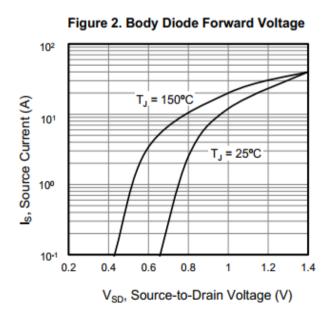
Source-Drain Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Is	Continuous Source Current			18	Α	Integral pn-diode
Isм	Maximum Pulsed Current			72	Α	in MOSFET
VsD	Diode Forward Voltage			1.4	V	IS=18A,VGS=0V
trr	Reverse Recovery Time		570.3		nS	VGS=0V
Qrr	Reverse Recovery Charge		7.35		μC	IS=18A,di/dt=100A/µs

Notes:

Typical Feature curve

Figure 1. Output Characteristics (T_J = 25°C) 20V 30 10V 8V Ip, Drain Current (A) 7V 6V 20 15 10 5 0 16 20 V_{DS}, Drain-to-Source Voltage (V)



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^{*1.}TJ=±25°C to +150°C.

^{*2.}Repetitive rating; pulse width limited by maximum junction temperature.

^{*3.}Pulse width≤300µs;duty cycle ≤1%.

^{*4.}Basically not affected by temperature.



Ip, Drain Current (A)



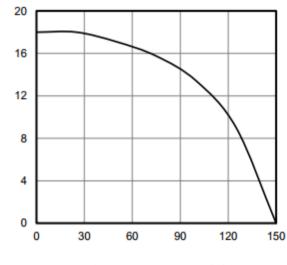
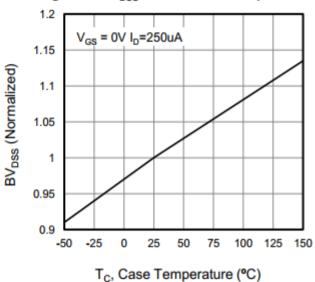


Figure 4. BV_{DSS} Variation vs. Temperature



T_C, Case Temperature (A)

Figure 5. Transfer Characteristics

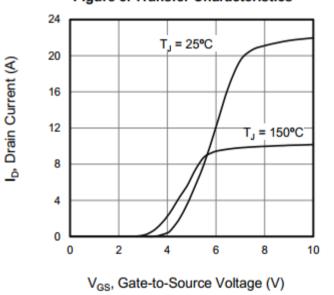
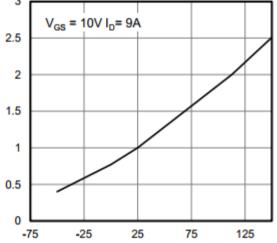


Figure 6. On-Resistance vs. Temperature R_{DS(m)}, On-Resistance (Normalized) V_{GS} = 10V I_D= 9A



T_J, Junction Temperature (°C)



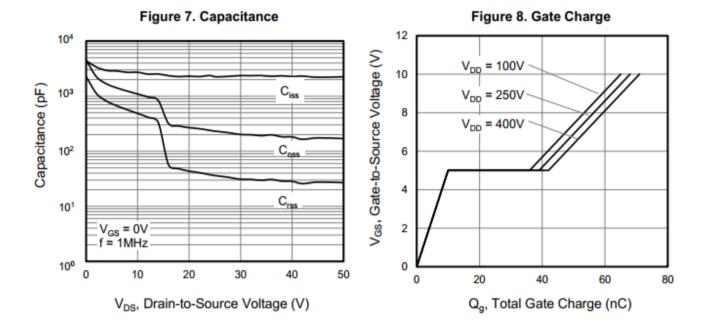
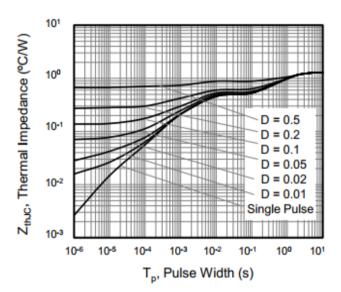


Figure 9. Transient Thermal Impedance





Test Circuits and Waveforms

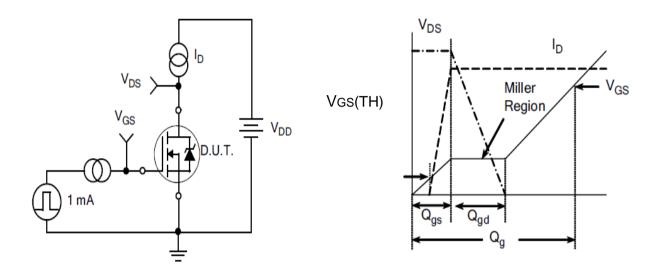


Figure 10.
Gate Charge Test Circuit

Figure 11.
Gate Charge Waveform

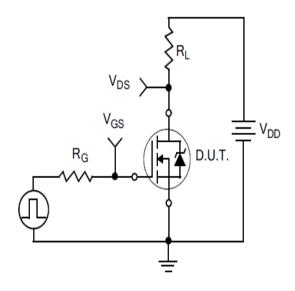


Figure 12.
Resistive Switching Test Circuit

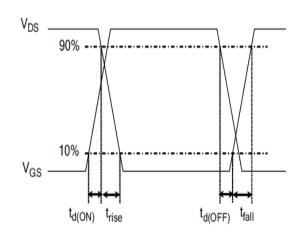


Figure 13.
Resistive Switching Waveforms

Test Circuits and Waveforms

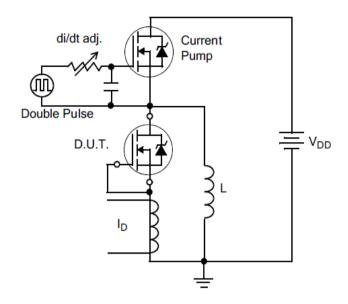


Figure14.Diode Reverse Recovery
Test Circuit

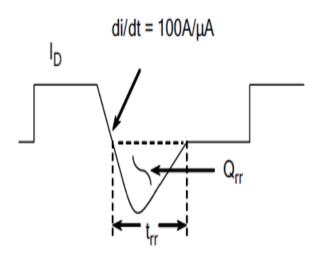


Figure 15. Diode Reverse Recovery Waveform

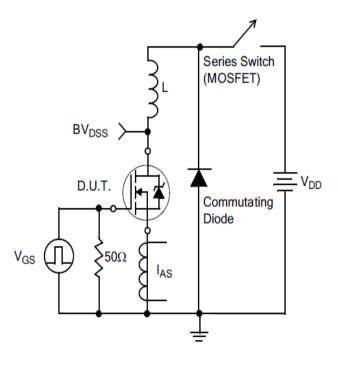
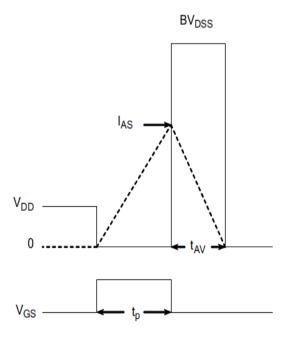


Figure 16. Unclamped Inductive Switching Test Circuit



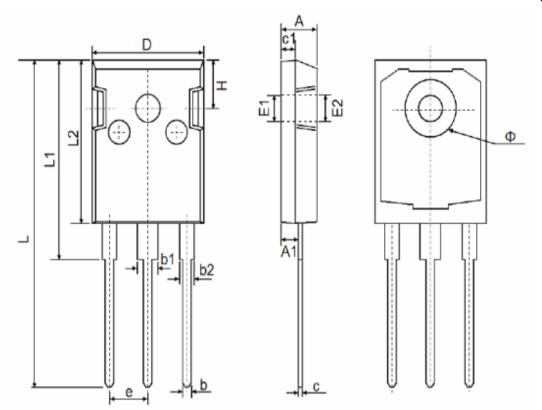
$$EAS = \frac{IAS^2L}{2}$$

Figure 17. Unclamped Inductive Switching Waveforms



Package outline drawing

Unit:mm



TO-247

Complete L	Dimensions	In Millimeters	Dimensions In Inches			
Symbol	Min.	Max.	Min.	Max.		
A	4.850	5.150	0.191	0.200		
A1	2.200	2.600	0.087	0.102		
b	1.000	1.400	0.039	0.055		
b1	2.800	3.200	0.110	0.126		
b2	1.800	2.200	0.071	0.087		
С	0.500	0.700	0.020	0.028		
c1	1.900	2.100	0.075	0.083		
D	15.450	15.750	0.608	0.620		
E1	3.500) REF	0.138	REF		
E2	3.600) REF	0.142	REF		
L	40.900	41.300	1.610	1.626		
L1	24.800	25.100	0.976	0.988		
L2	20.300	20.600	0.799	0.811		
Φ	7.100	7.300	0.280	0.287		
е	5.450) TYP	YP 0.215 TYP			
Н	5.980) REF	0.235	REF		

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DMN1017UCP3-7 EFC2J004NUZTDG P85W28HP2F-7071 DMN1053UCP4-7 NTE2384 DMC2700UDMQ-7 DMN2080UCB4-7
DMN61D9UWQ-13 US6M2GTR DMN31D5UDJ-7 DMP22D4UFO-7B IPS60R3K4CEAKMA1 DMN1006UCA6-7 DMN16M9UCA6-7
STF5N65M6 IRF40H233XTMA1 STU5N65M6 DMN6022SSD-13 DMN13M9UCA6-7 DMTH10H4M6SPS-13 IPS60R360PFD7SAKMA1
DMN2990UFB-7B SSM3K35CT,L3F IPLK60R1K0PFD7ATMA1 2N7002W-G MCAC30N06Y-TP IPWS65R035CFD7AXKSA1
MCQ7328-TP SSM3J143TU,LXHF DMN12M3UCA6-7 PJMF280N65E1_T0_00201 PJMF380N65E1_T0_00201
PJMF280N60E1 T0 00201 PJMF600N65E1 T0 00201 PJMF900N65E1 T0 00201